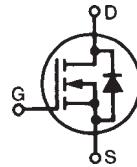


High Voltage Power MOSFET

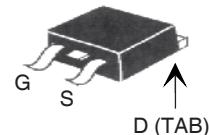
IXTA05N100
IXTP05N100

V_{DSS} = **1000V**
I_{D25} = **750mA**
R_{DS(on)} ≤ **17Ω**

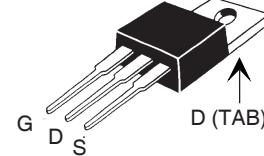
N-Channel Enhancement Mode
Avalanche Rated



TO-263 (IXTA)



TO-220 (IXTP)



G = Gate D = Drain
S = Source TAB = Drain

Symbol	Test Conditions	Maximum Ratings		
V _{DSS}	T _J = 25°C to 150°C	1000	V	
V _{DGR}	T _J = 25°C to 150°C, R _{GS} = 1MΩ	1000	V	
V _{GSS}	Continuous	±30	V	
V _{GSM}	Transient	±40	V	
I _{D25}	T _C = 25°C	750	mA	
I _{DM}	T _C = 25°C, pulse width limited by T _{JM}	3	A	
I _A	T _C = 25°C	1	A	
E _{AS}	T _C = 25°C	100	mJ	
dv/dt	I _S ≤ I _{DM} , V _{DD} ≤ V _{DSS} , T _J = 150°C	3	V/ns	
P _D	T _C = 25°C	40	W	
T _J		-55 ... +150	°C	
T _{JM}		150	°C	
T _{stg}		-55 ... +150	°C	
T _L	1.6mm (0.062 in.) from case for 10s	300	°C	
T _{SOLD}	Plastic body for 10s	260	°C	
M _d	Mounting torque (TO-220)	1.13 / 10	Nm/lb.in.	
Weight	TO-220 TO-263	3.0 2.5	g g	

Features

- International standard packages
- Fast intrinsic diode
- Fast switching times
- Avalanche Rated
- High voltage, R_{ds(on)} HDMOS™ process
- Rugged polysilicon gate cell structure
- Extended FBSOA

Applications

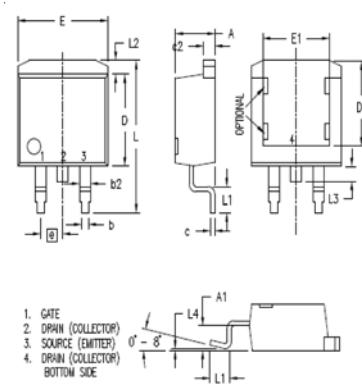
- Switch-mode and resonant-mode power supplies
- Flyback inverters
- DC choppers
- High frequency matching

Advantages

- High power density
- Space savings

Symbol	Test Conditions (T _J = 25°C, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
BV _{DSS}	V _{GS} = 0V, I _D = 250μA	1000		V
V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	2.5		V
I _{GSS}	V _{GS} = ± 30V, V _{DS} = 0V			±100 nA
I _{DSS}	V _{DS} = V _{DSS} V _{GS} = 0V			25 μA
		T _J = 125°C		500 μA
R _{DS(on)}	V _{GS} = 10V, I _D = 375mA, Note 1			17 Ω

Symbol	Test Conditions ($T_J = 25^\circ\text{C}$, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
g_{fs}	$V_{DS} = 20\text{V}$, $I_D = 500\text{mA}$, Note 1	0.55	0.93	S
C_{iss} C_{oss} C_{rss}	$V_{GS} = 0\text{V}$, $V_{DS} = 25\text{V}$, $f = 1\text{MHz}$	260	pF	
		22	pF	
		8	pF	
$t_{d(on)}$ t_r $t_{d(off)}$ t_f	Resistive Switching Times $V_{GS} = 10\text{V}$, $V_{DS} = 0.5 \cdot V_{DSS}$, $I_D = 1\text{A}$ $R_G = 47\Omega$ (External)	11	ns	
		19	ns	
		40	ns	
		28	ns	
$Q_{g(on)}$ Q_{gs} Q_{gd}	$V_{GS} = 10\text{V}$, $V_{DS} = 0.5 \cdot V_{DSS}$, $I_D = 1\text{A}$	7.8	nC	
		1.4	nC	
		4.1	nC	
R_{thJC}			3.1	$^\circ\text{C}/\text{W}$
R_{thCS}	(TO-220)	0.50		$^\circ\text{C}/\text{W}$

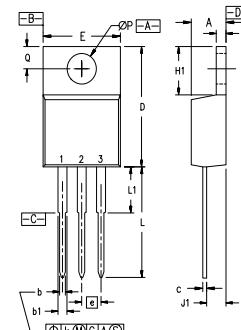
TO-263 (IXTA) Outline


SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.160	.190	4.06	4.83
A1	.080	.110	2.03	2.79
b	.020	.039	0.51	0.99
b2	.045	.055	1.14	1.40
c	.016	.029	0.40	0.74
c2	.045	.055	1.14	1.40
D	.340	.380	8.64	9.65
D1	.315	.350	8.00	8.89
E	.380	.410	9.65	10.41
E1	.245	.320	6.22	8.13
e	.100 BSC		2.54 BSC	
L	.575	.625	14.61	15.88
L1	.090	.110	2.29	2.79
L2	.040	.055	1.02	1.40
L3	.050	.070	1.27	1.78
L4	0	.005	0	0.13

Source-Drain Diode

Symbol	Test Conditions ($T_J = 25^\circ\text{C}$, unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
I_s	$V_{GS} = 0\text{V}$		750	mA
I_{SM}	Repetitive, pulse width limited by T_{JM}		3	A
V_{SD}	$I_F = I_S$, $V_{GS} = 0\text{V}$, Note 1		1.5	V
t_{rr}	$I_F = I_S$, $-di/dt = 100\text{A}/\mu\text{s}$ $V_R = 100\text{V}$, $V_{GS} = 0\text{V}$	710		ns

Note 1: Pulse test, $t \leq 300\mu\text{s}$; duty cycle, $d \leq 2\%$.

TO-220 (IXTP) Outline


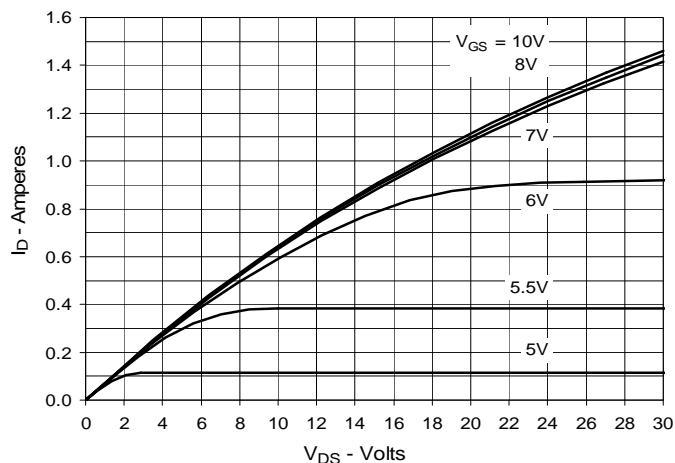
Pins: 1 - Gate 2 - Drain
3 - Source 4 - Drain

SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.170	.190	4.32	4.83
b	.025	.040	0.64	1.02
b1	.045	.065	1.15	1.65
c	.014	.022	0.35	0.56
D	.580	.630	14.73	16.00
E	.390	.420	9.91	10.66
e	.100 BSC		2.54 BSC	
F	.045	.055	1.14	1.40
H1	.230	.270	5.85	6.85
J1	.090	.110	2.29	2.79
K	0	.015	0	0.38
L	.500	.550	12.70	13.97
L1	.110	.230	2.79	5.84
$\emptyset P$.139	.161	3.53	4.08
Q	.100	.125	2.54	3.18

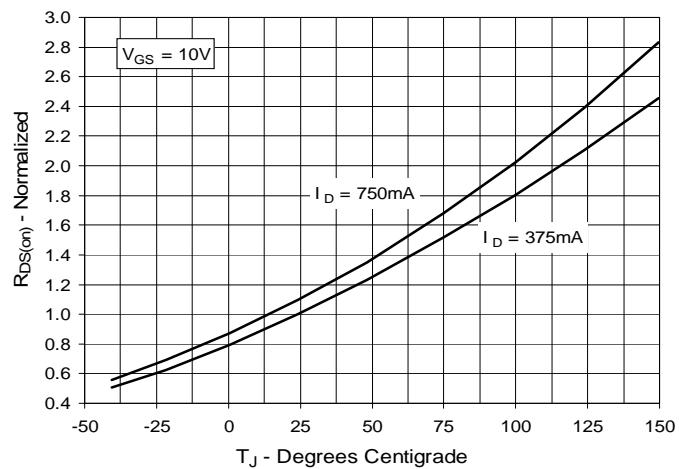
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 7,157,338B2 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537

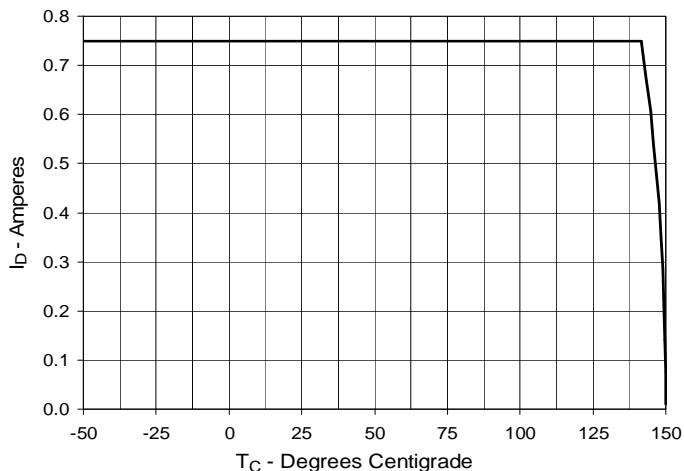
**Fig. 1. Output Characteristics
@ 25°C**



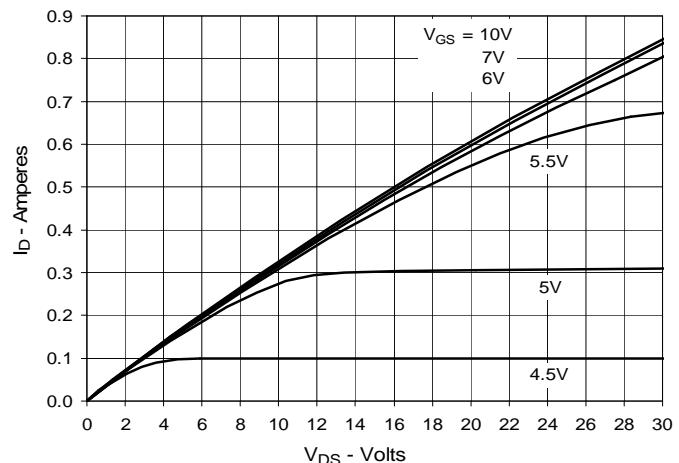
**Fig. 3. $R_{DS(on)}$ Normalized to $I_D = 375\text{mA}$
Value vs. Junction Temperature**



**Fig. 5. Maximum Drain Current vs.
Case Temperature**



**Fig. 2. Output Characteristics
@ 125°C**



**Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 375\text{mA}$
Value vs. Drain Current**

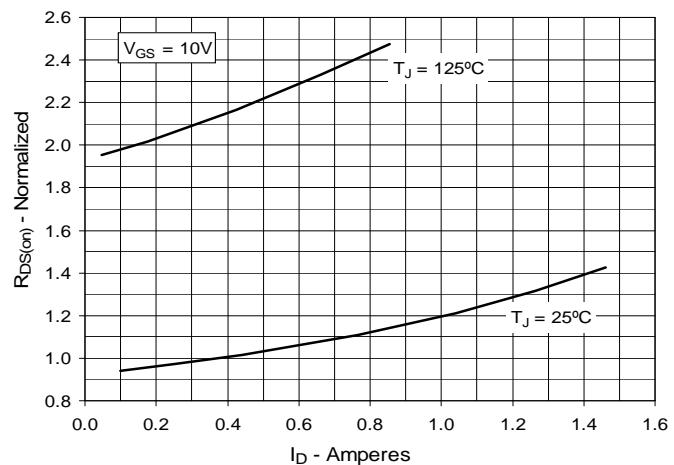


Fig. 6. Input Admittance

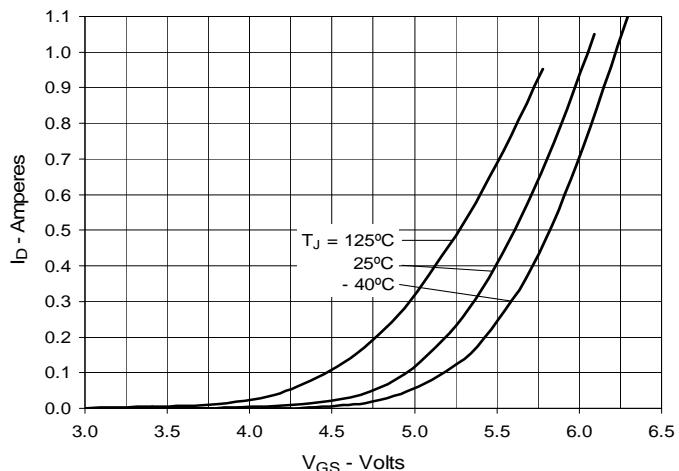
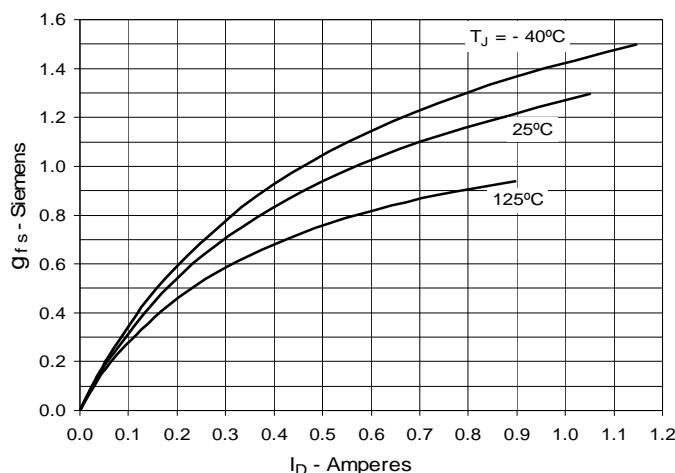
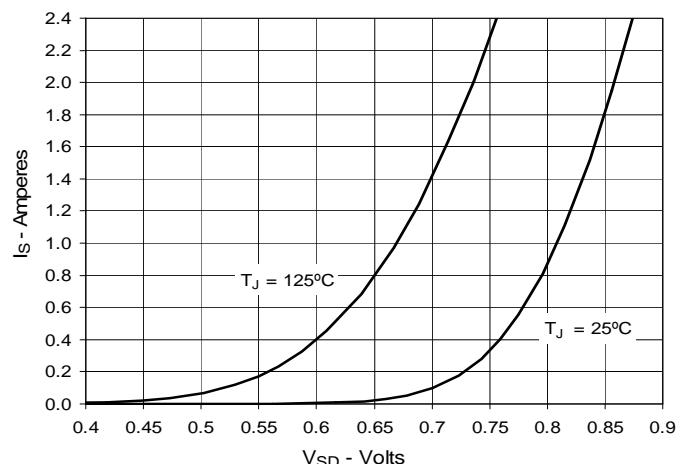
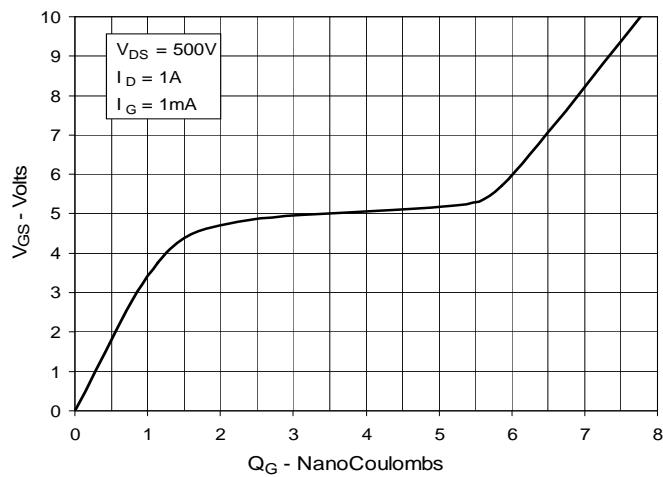
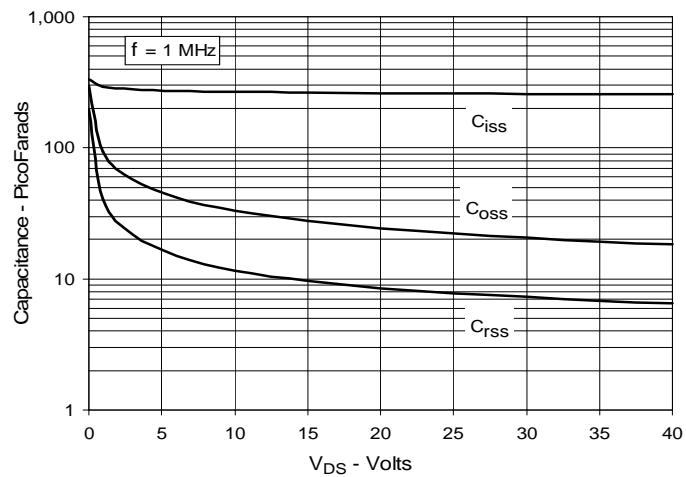
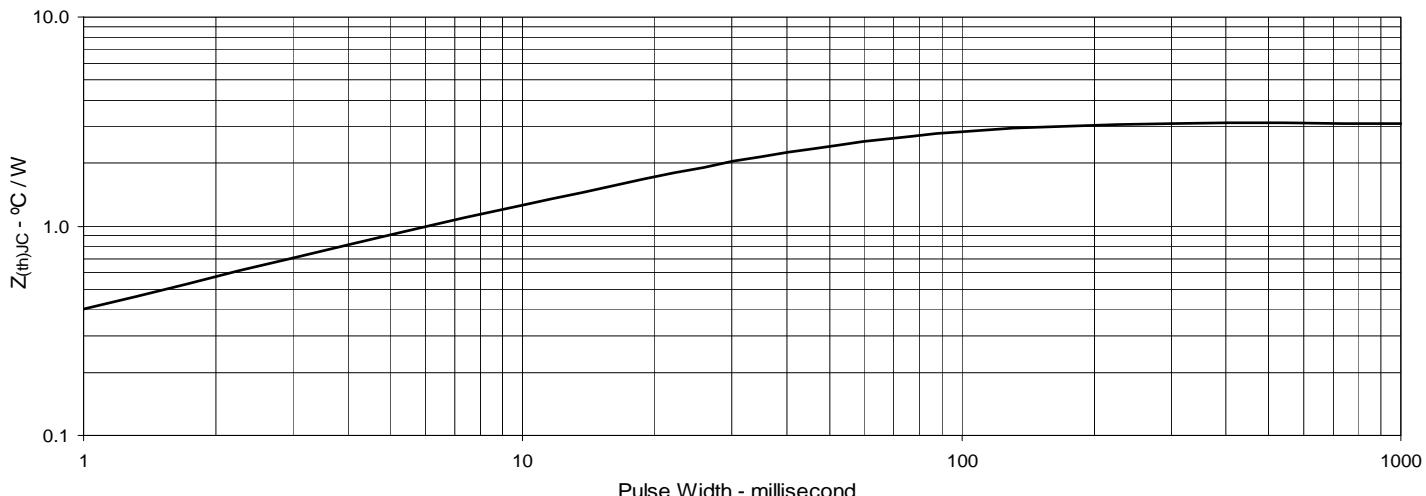


Fig. 7. Transconductance

Fig. 8. Forward Voltage Drop of Intrinsic Diode

Fig. 9. Gate Charge

Fig. 10. Capacitance

Fig. 11. Maximum Transient Thermal Impedance


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